

TOSHIBA Field Effect Transistor Silicon P, N Channel MOS Type
(P Channel π -MOSV/N Channel π -MOSV)

TPC8404

Motor Dreive

Switching Regulator Applications

- Low drain-source ON resistance: P Channel $R_{DS(ON)} = 1.85 \Omega$ (typ.)
N Channel $R_{DS(ON)} = 1.2 \Omega$ (typ.)
- High forward transfer admittance: P Channel $|Y_{fs}| = 1.1 \text{ S}$ (typ.)
N Channel $|Y_{fs}| = 1.3 \text{ S}$ (typ.)
- Low leakage current: P Channel $I_{DSS} = -100 \mu\text{A}$ ($V_{DS} = -250\text{V}$)
N Channel $I_{DSS} = 100 \mu\text{A}$ ($V_{DS} = 250\text{V}$)
- Enhancement-mode
: P Channel $V_{th} = -1.5 \sim -3.5 \text{ V}$ ($V_{DS} = -10 \text{ V}$, $I_D = -1 \text{ mA}$)
: N Channel $V_{th} = 1.5 \sim 3.5 \text{ V}$ ($V_{DS} = 10 \text{ V}$, $I_D = 1 \text{ mA}$)

Absolute Maximum Ratings ($T_a = 25^\circ\text{C}$)

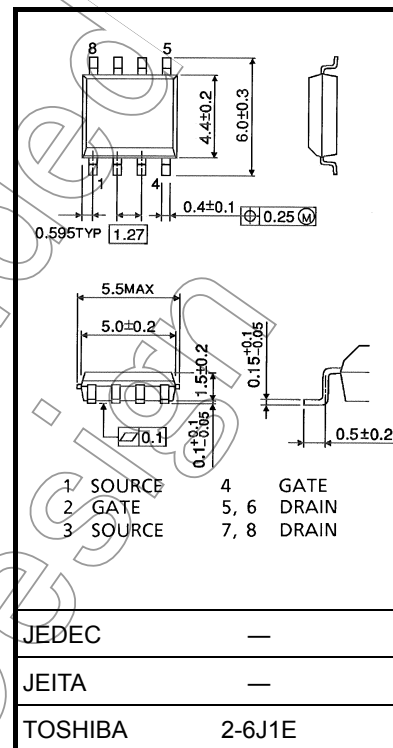
Characteristics		Symbol	Rating		Unit
			P Channel	N Channel	
Drain-source voltage		V_{DSS}	-250	250	V
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V_{DGR}	-250	250	V
Gate-source voltage		V_{GSS}	± 20	± 20	V
Drain current	DC (Note 1)	I_D	-0.9	1.1	A
	Pulse (Note 1)	I_{DP}	-3.9	4.4	
Drain power dissipation ($t = 10\text{s}$) (Note 2a)	Single-device operation (Note 3a)	$P_{D(1)}$	1.5	1.5	W
	Single-device value at dual operation (Note 3b)	$P_{D(2)}$	1.1	1.1	
Drain power dissipation ($t = 10\text{s}$) (Note 2b)	Single-device operation (Note 3a)	$P_{D(1)}$	0.75	0.75	
	Single-device value at dual operation (Note 3b)	$P_{D(2)}$	0.45	0.45	
Single pulse avalanche energy		E_{AS}	0.49 (Note 4a)	0.49 (Note 4b)	mJ
Avalanche current		I_{AR}	-0.9	1.1	A
Repetitive avalanche energy Single-device value at operation (Note 2a, 3b, 5)		E_{AR}	0.11		mJ
Channel temperature		T_{ch}	150		$^\circ\text{C}$
Storage temperature range		T_{stg}	$-55 \sim 150$		$^\circ\text{C}$

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

Note: (Note 1), (Note 2ab), (Note 3ab), (Note 4), (Note 5) Please see next page.

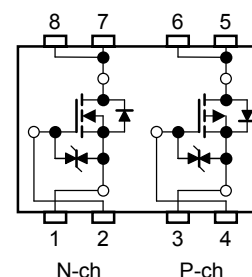
This transistor is an electrostatic sensitive device. Please handle with caution.

Unit: mm



Weight: 0.080 g (typ.)

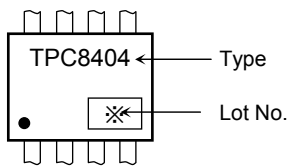
Circuit Configuration



Thermal Characteristics

Characteristics		Symbol	Max	Unit
Thermal resistance, channel to ambient (t = 10s) (Note 2a)	Single-device operation (Note 3a)	R _{th} (ch-a) (1)	83.3	°C/W
	Single-device value at dual operation (Note 3b)	R _{th} (ch-a) (2)	114	
Thermal resistance, channel to ambient (t = 10s) (Note 2b)	Single-device operation (Note 2a)	R _{th} (ch-a) (1)	167	
	Single-device value at dual operation (Note 2b)	R _{th} (ch-a) (2)	278	

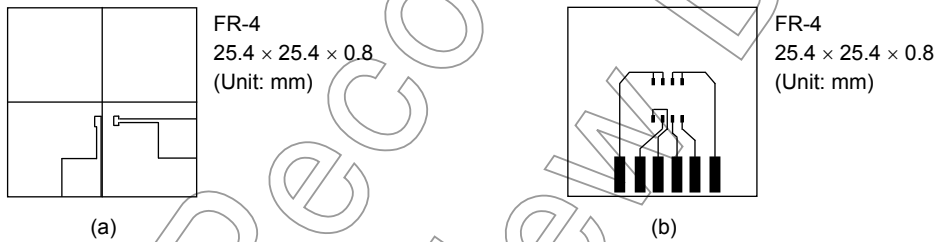
Marking



Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2:

- a) Device mounted on a glass-epoxy board (a) b) Device mounted on a glass-epoxy board (b)



Note 3:

- a) The power dissipation and thermal resistance values are shown for a single device (During single-device operation, power is only applied to one device.).
b) The power dissipation and thermal resistance values are shown for a single device (During dual operation, power is evenly applied to both devices.).

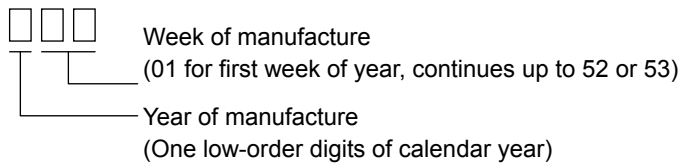
Note 4:

- a) V_{DD} = -50 V, T_{ch} = 25°C (Initial), L = 1.0 mH, R_G = 25 Ω, I_{AR} = -0.9 A
b) V_{DD} = 50 V, T_{ch} = 25°C (Initial), L = 1.0 mH, R_G = 25 Ω, I_{AR} = 1.1 A

Note 5: Repetitive rating; pulse width limited by max channel temperature.

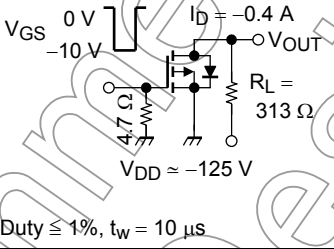
Note 6: • on lower left of the marking indicates Pin 1.

※ Weekly code: (Three digits)



P-ch

Electrical Characteristics (Ta = 25°C)

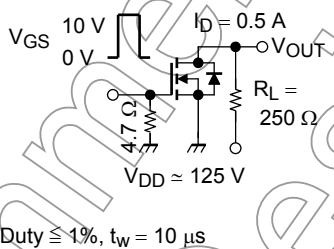
Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current		I_{GSS}	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0 \text{ V}$	—	—	± 10	μA
Drain cut-OFF current		I_{DSS}	$V_{DS} = -250 \text{ V}, V_{GS} = 0 \text{ V}$	—	—	-100	μA
Drain-source breakdown voltage		$V_{(BR)DSS}$	$I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$	-250	—	—	V
Gate threshold voltage		V_{th}	$V_{DS} = -10 \text{ V}, I_D = -1 \text{ mA}$	-1.5	—	-3.5	V
Drain-source ON resistance		$R_{DS(ON)}$	$V_{GS} = -10 \text{ V}, I_D = -0.9 \text{ A}$	—	1.85	2.55	Ω
Forward transfer admittance		$ Y_{fs} $	$V_{DS} = -10 \text{ V}, I_D = -0.4 \text{ A}$	0.4	1.1	—	S
Input capacitance		C_{iss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	—	381	—	pF
Reverse transfer capacitance		C_{rss}		—	52	—	
Output capacitance		C_{oss}		—	157	—	
Switching time	Rise time	t_r		—	8	—	ns
	Turn-ON time	t_{on}		—	20	—	
	Fall time	t_f		—	17	—	
	Turn-OFF time	t_{off}		—	60	—	
Total gate charge (gate-source plus gate-drain)		Q_g	$V_{DD} \approx -200 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -0.9 \text{ A}$	—	12	—	nC
Gate-source charge 1		Q_{gs}		—	7	—	
Gate-drain ("miller") charge		Q_{gd}		—	5	—	

Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Drain reverse current	Pulse (Note 1)	I_{DRP}	—	—	—	-3.6	A
Forward voltage (diode)		V_{DSF}	$I_{DR} = -0.9 \text{ A}, V_{GS} = 0 \text{ V}$	—	—	2.0	V
Reverse recovery time		t_{rr}	$I_{DR} = -0.9 \text{ A}, V_{GS} = 0 \text{ V}$	—	110	—	V
Reverse recovery charge		Q_{rr}	$dI_{DR}/dt = -100 \text{ A}/\mu\text{sV}$	—	550	—	V

N-ch

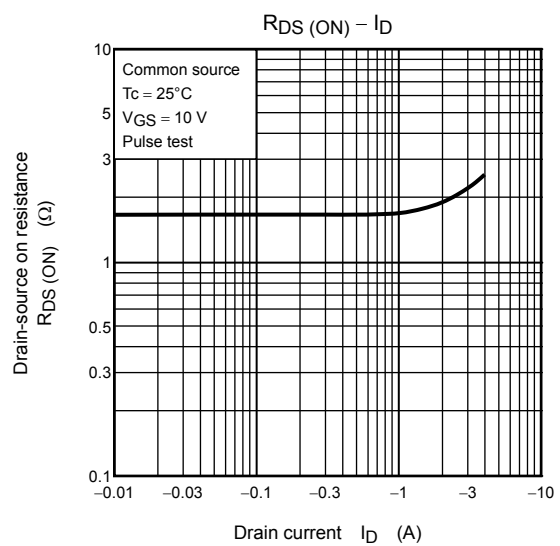
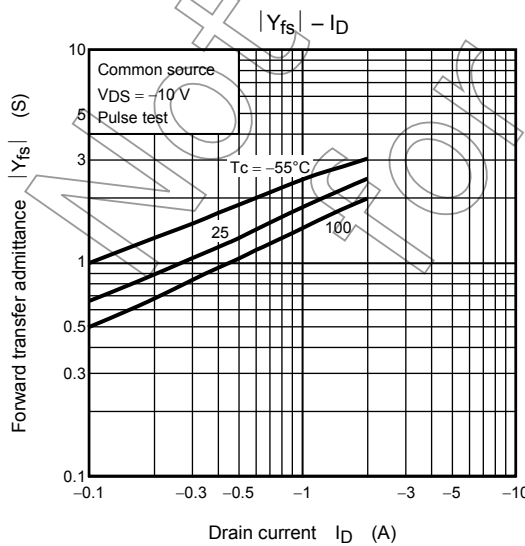
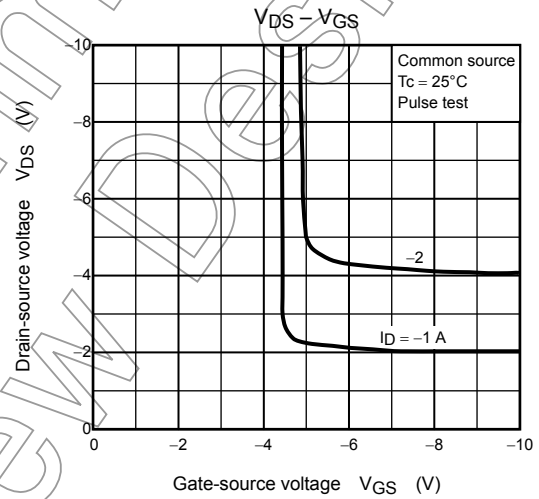
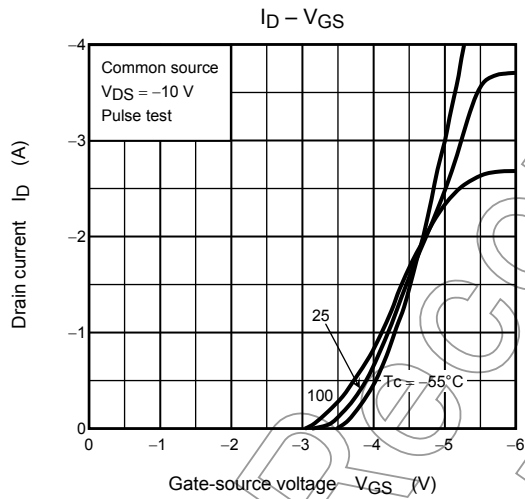
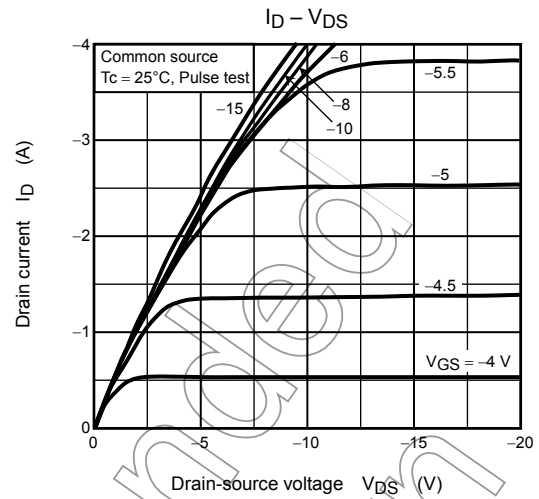
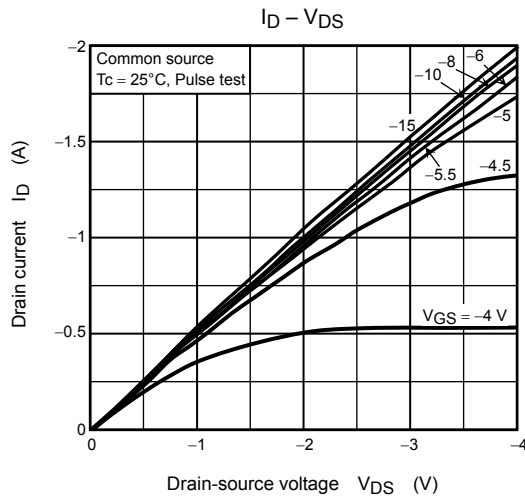
Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current		I_{GSS}	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0 \text{ V}$	—	—	± 10	μA
Drain cut-OFF current		I_{DSS}	$V_{DS} = 250 \text{ V}, V_{GS} = 0 \text{ V}$	—	—	100	μA
Drain-source breakdown voltage		$V_{(BR)DSS}$	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	250	—	—	V
Gate threshold voltage		V_{th}	$V_{DS} = 10 \text{ V}, I_D = 1 \text{ mA}$	1.5	—	3.5	V
Drain-source ON resistance		$R_{DS(ON)}$	$V_{GS} = 10 \text{ V}, I_D = 1.1 \text{ A}$	—	1.2	1.7	Ω
Forward transfer admittance		$ Y_{fs} $	$V_{DS} = 10 \text{ V}, I_D = 0.5 \text{ A}$	0.5	1.3	—	S
Input capacitance		C_{iss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	—	267	—	pF
Reverse transfer capacitance		C_{rss}		—	32	—	
Output capacitance		C_{oss}		—	98	—	
Switching time	Rise time	t_r		—	6	—	ns
	Turn-ON time	t_{on}		—	15	—	
	Fall time	t_f		—	10	—	
	Turn-OFF time	t_{off}		—	35	—	
Total gate charge (gate-source plus gate-drain)		Q_g	$V_{DD} \approx 200 \text{ V}, V_{GS} = 10 \text{ V},$	—	10	—	nC
Gate-source charge 1		Q_{gs}	$I_D = 1.1 \text{ A}$	—	6	—	
Gate-drain ("miller") charge		Q_{gd}		—	4	—	

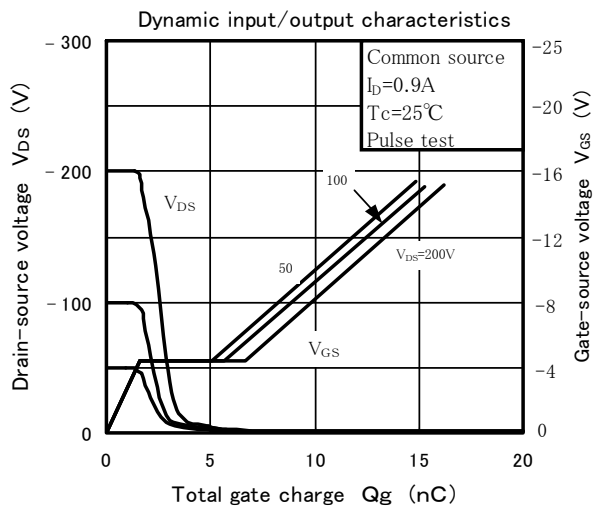
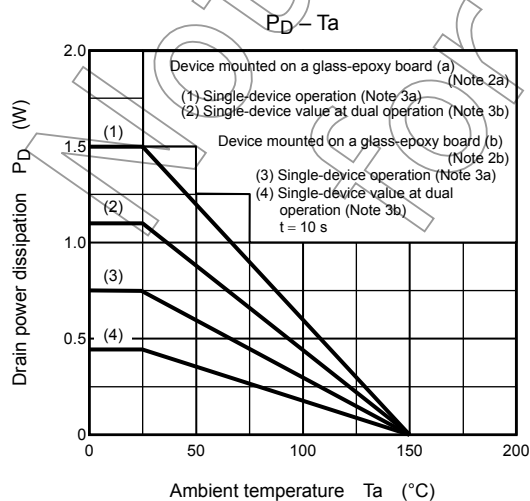
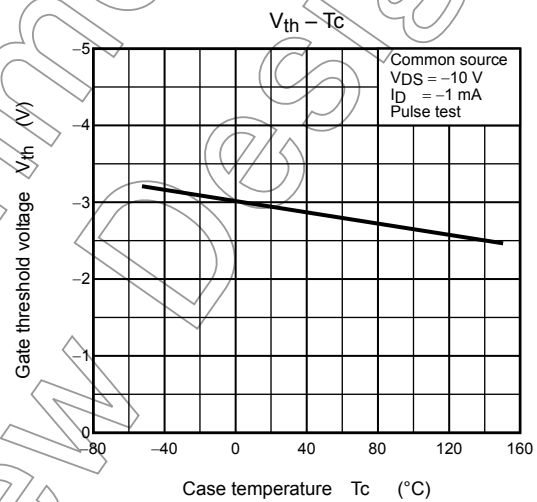
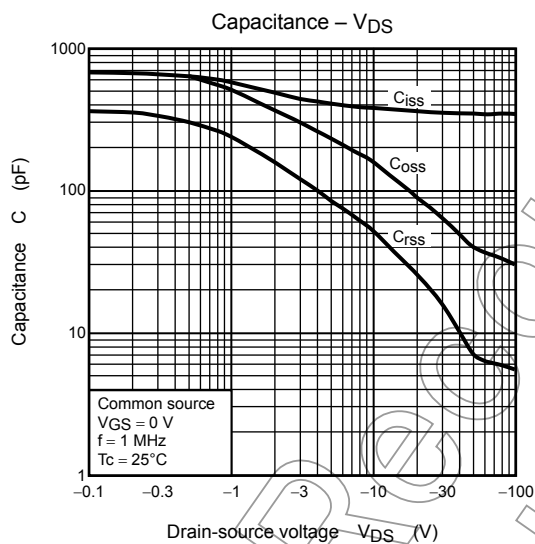
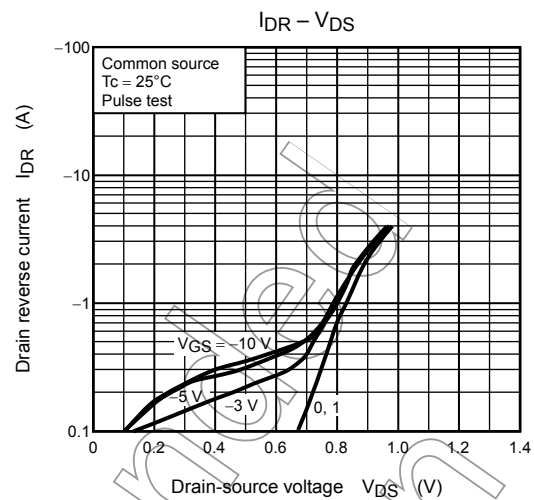
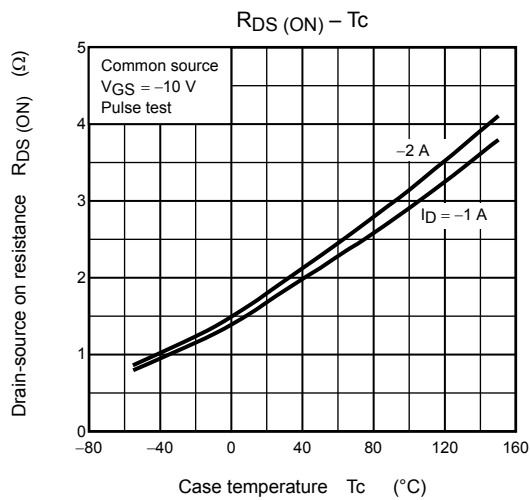
Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Drain reverse current	Pulse (Note 1)	I_{DRP}	—	—	—	4.4	A
Forward voltage (diode)		V_{DSF}	$I_{DR} = 1.1 \text{ A}, V_{GS} = 0 \text{ V}$	—	—	-2.0	V
Reverse recovery time		t_{rr}	$I_{DR} = 1.1 \text{ A}, V_{GS} = 0 \text{ V},$	—	100	—	ns
Reverse recovery charge		Q_{rr}	$dI_{DR}/dt = 100 \text{ A}/\mu\text{s}$	—	320	—	nC

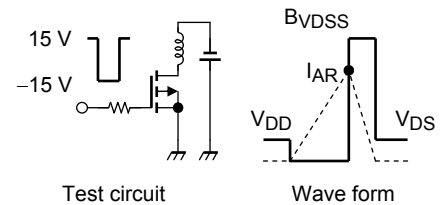
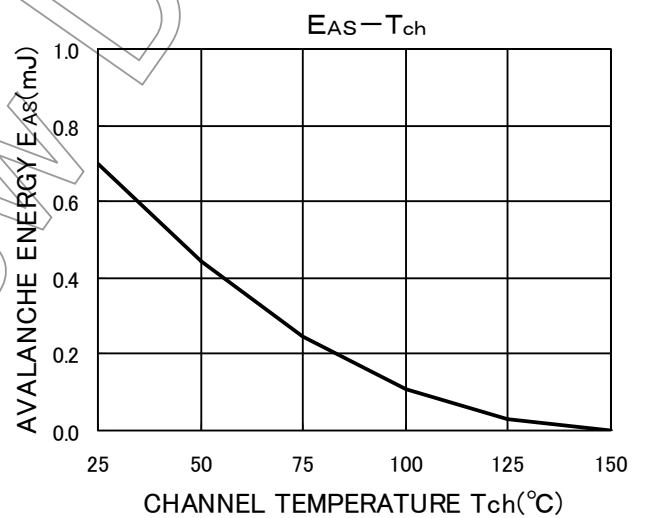
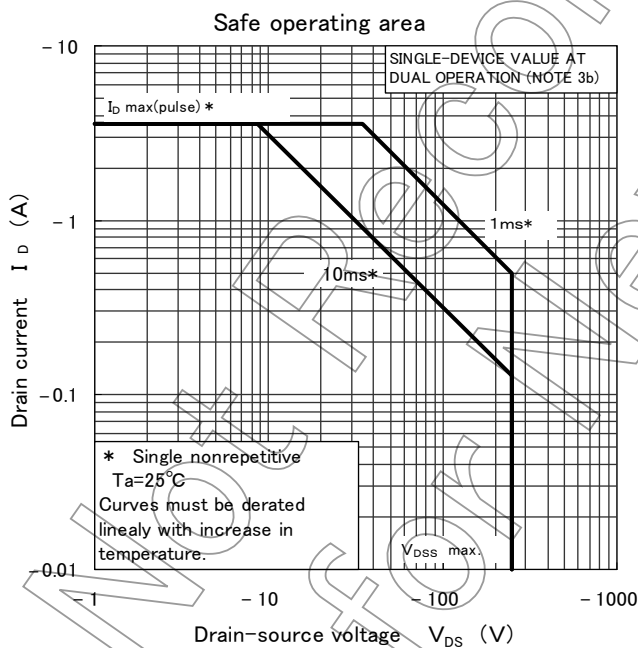
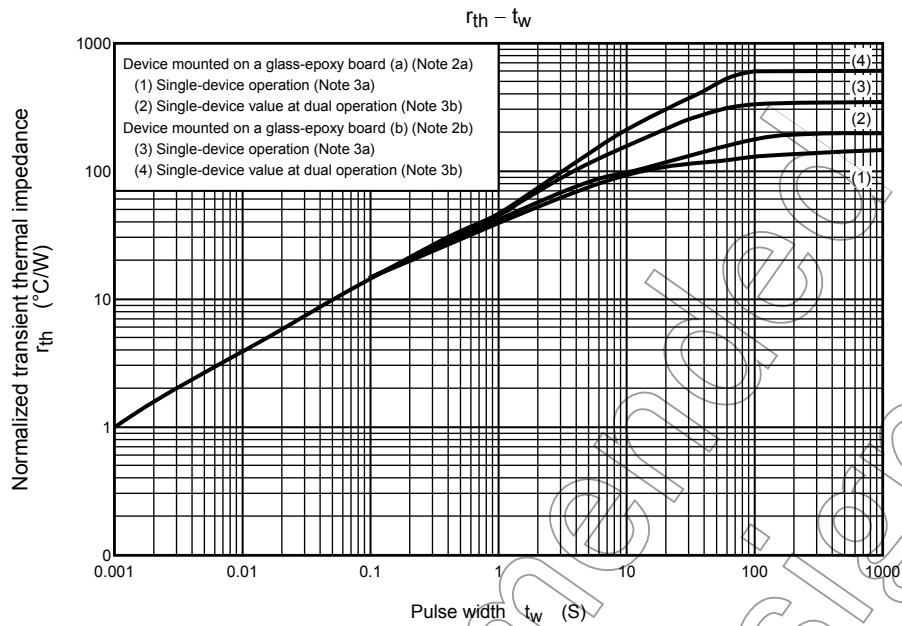
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P-ch



P-ch

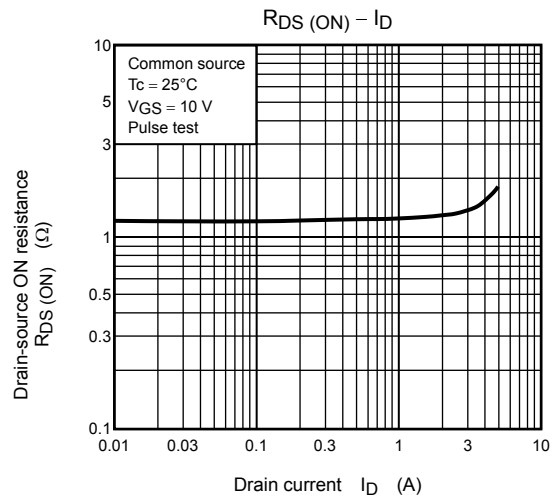
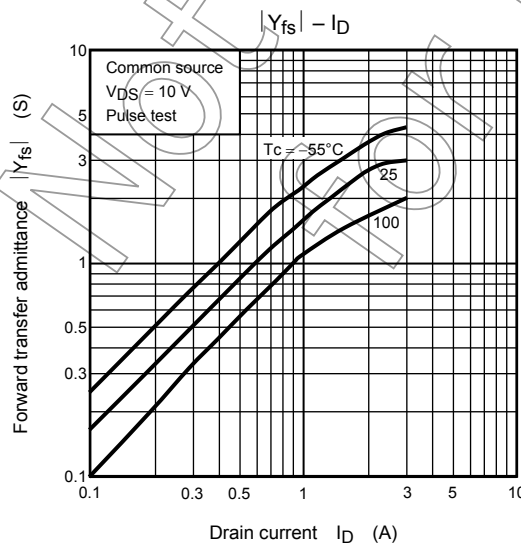
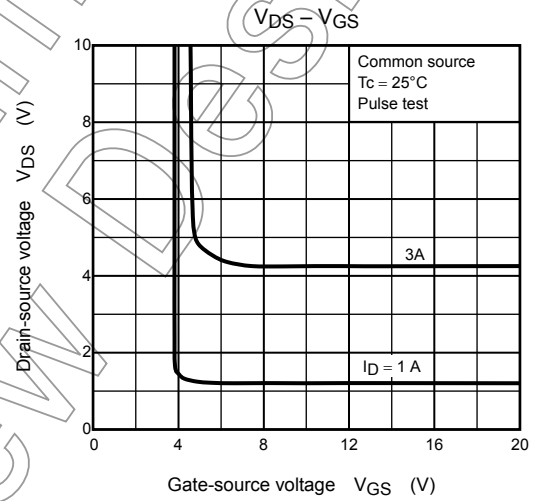
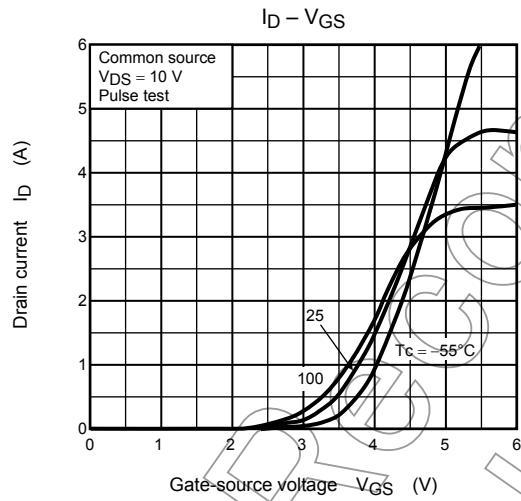
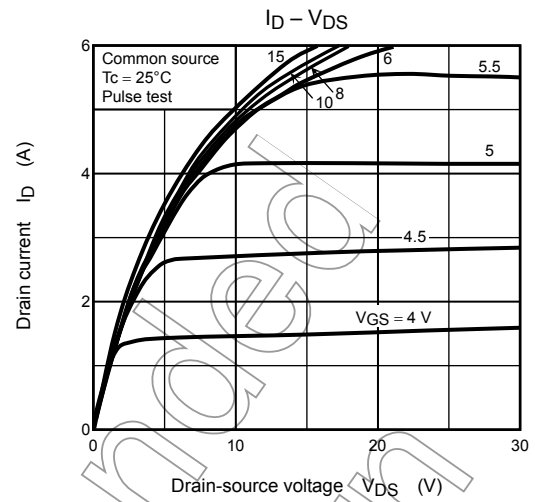
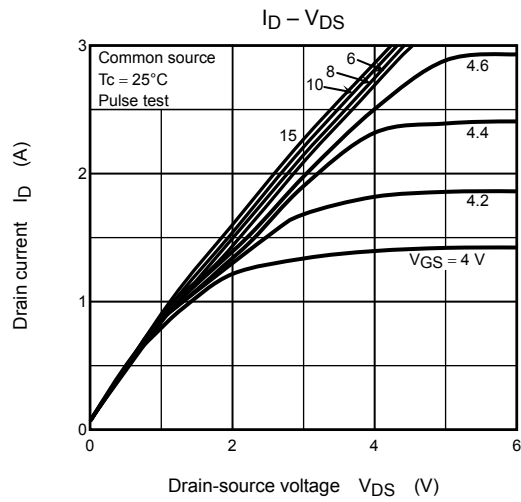


$$R_G = 25 \, \Omega$$

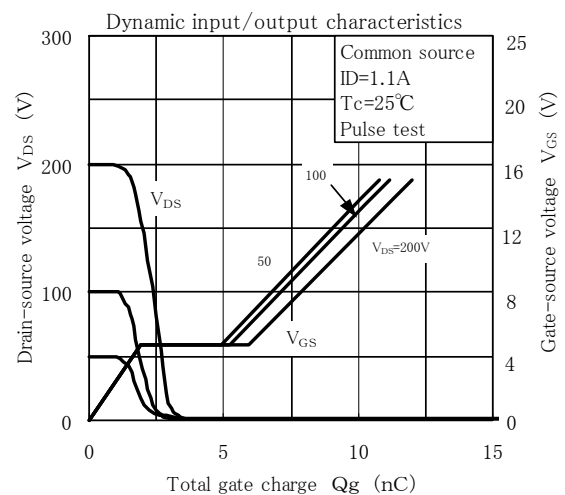
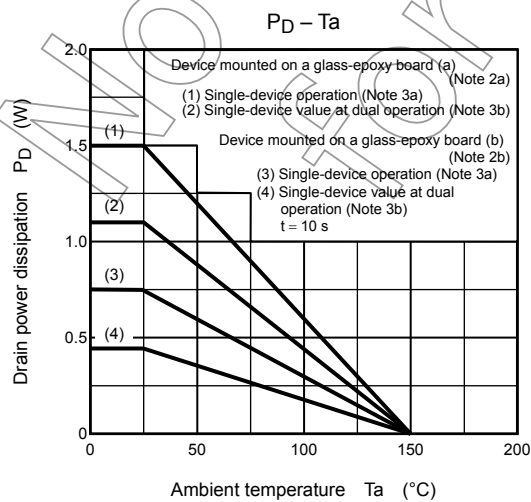
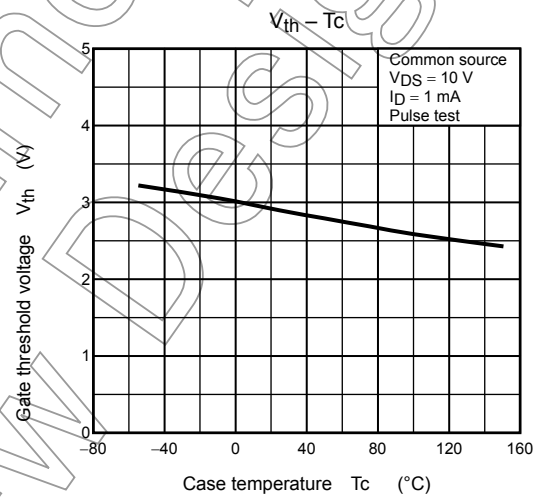
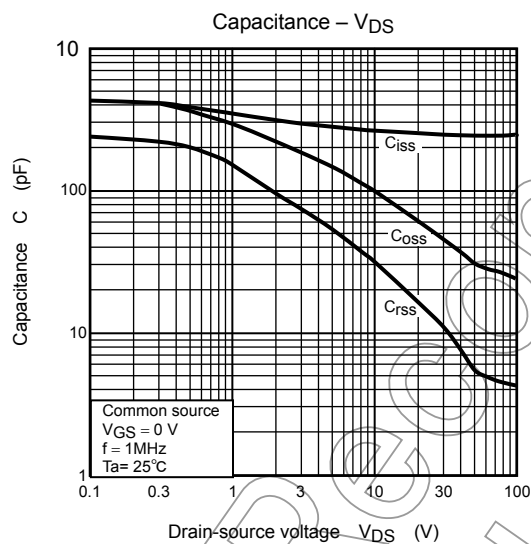
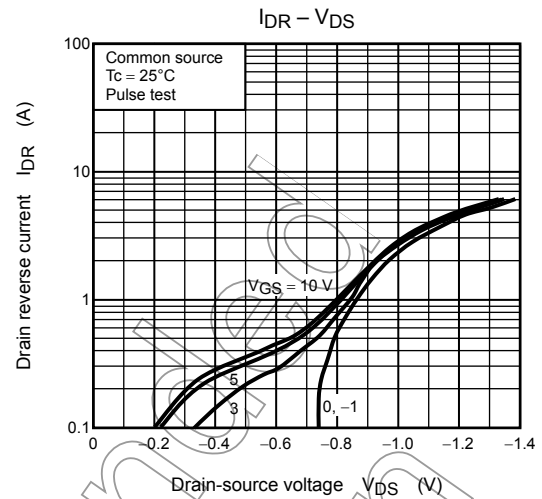
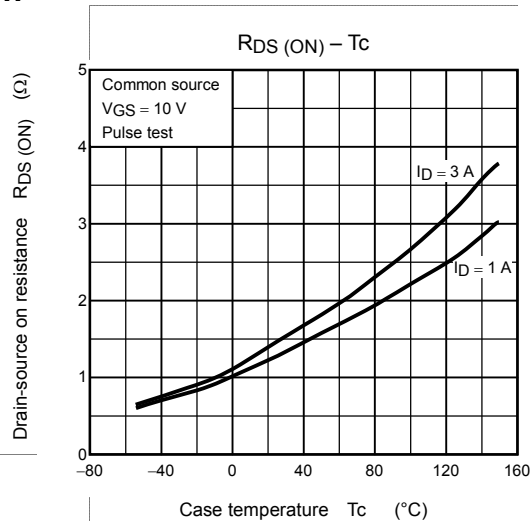
$$V_{DD} = -50 \, \text{V}, L = 1 \, \text{mH}$$

$$E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{B_{VDS}}{B_{VDS} - V_{DD}} \right)$$

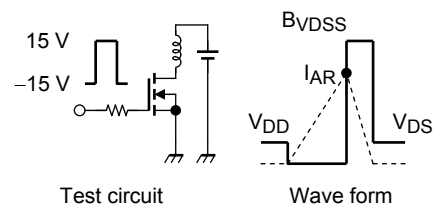
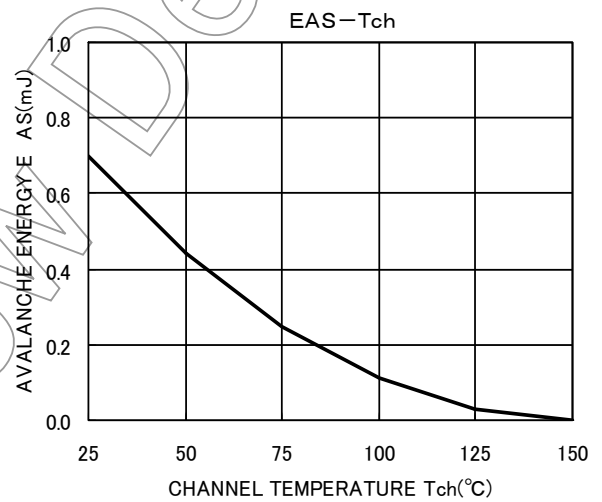
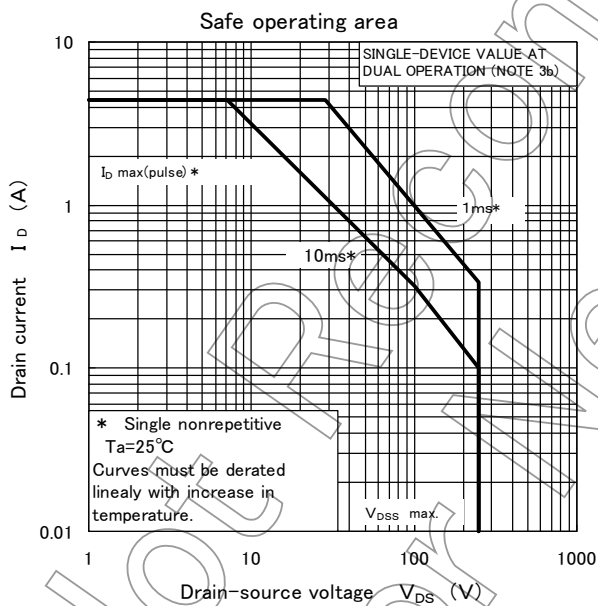
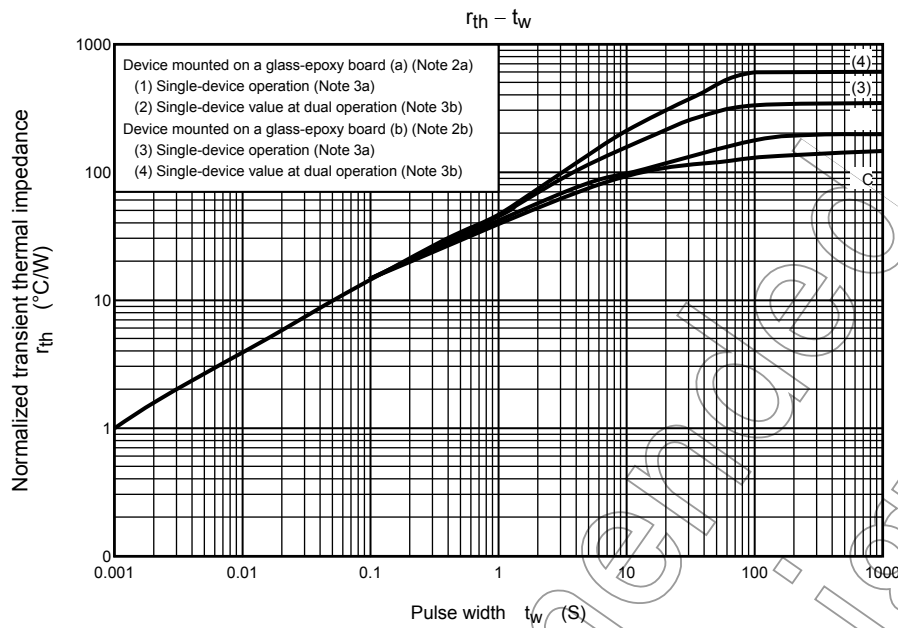
N-ch



N-ch



N-ch



$R_G = 25\ \Omega$
 $V_{DD} = 50\text{ V}$, $L = 1\text{ mH}$

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